


<b>Search Notes</b>  	<b>Application/Control No.</b>  10552976	<b>Applicant(s)/Patent Under Reexamination</b>  MATSUDA, YOJIRO
	<b>Examiner</b>  JASON M MANDEVILLE	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	107, 84	21 May 2009	Jason Mandeville
430	31-38	21 May 2009	Jason Mandeville
359	296	21 May 2009	Jason Mandeville
345	107, 84	11/18/2009	Jason Mandeville
430	31-38	11/18/2009	Jason Mandeville
359	296	11/18/2009	Jason Mandeville
345	107, 84	09/30/2011	Jason Mandeville
430	31-38	09/30/2011	Jason Mandeville
359	296	09/30/2011	Jason Mandeville

SEARCH NOTES		
Search Notes	Date	Examiner
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	21 May 2009	Jason Mandeville
Inventor Search	21 May 2009	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	11/18/2009	Jason Mandeville
Inventor Search	11/18/2009	Jason Mandeville
Searched US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM_TDB	09/30/2011	Jason Mandeville
Inventor Search	09/30/2011	Jason Mandeville

INTERFERENCE SEARCH
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	/JASON MANDEVILLE/ Primary Examiner.Art Unit 2629
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345	107, 84	09/30/2011	Jason Mandeville
359	296	09/30/2011	Jason Mandeville

	/JASON MANDEVILLE/ Primary Examiner.Art Unit 2629
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